

Direct observation of the transition from indirect to direct bandgap in atomically thin epitaxial MoSe₂

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Quantum systems in confined geometries are host to novel physical phenomena. Examples include quantum Hall systems in semiconductors¹ and Dirac electrons in graphene². Interest in such systems has also been intensified by the recent discovery of a large enhancement in photoluminescence quantum efficiency^{3–7} and a potential route to valleytronics^{6–8} in atomically thin layers of transition metal dichalcogenides, MX₂ (M = Mo, W; X = S, Se, Te), which are closely related to the indirect-to-direct bandgap transition in monolayers^{9–12}. Here, we report the first direct observation of the transition from indirect to direct bandgap in monolayer samples by using angle-resolved photoemission spectroscopy on high-quality thin films of MoSe₂ with variable thickness, grown by molecular beam epitaxy. The band structure measured experimentally indicates a stronger tendency of monolayer MoSe₂ towards a direct bandgap, as well as a larger gap size, than theoretically predicted. Moreover, our finding of a significant spin-splitting of ~180 meV at the valence band maximum of a monolayer MoSe₂ film could expand its possible application to spintronic devices.

The layered transition metal dichalcogenides (TMDs) MX₂ (M = Mo, W; X = S, Se, Te), a class of graphene-like two-dimensional materials, have attracted significant interest because they demonstrate quantum confinement at the single-layer limit¹³. As with graphene, these layered materials can be easily exfoliated mechanically to provide monolayers^{3–7,14–16} and assume a hexagonal honeycomb structure in which the M and X atoms are located at alternating corners of the hexagons. However, unlike graphene, which has a gapless Dirac cone band structure, MX₂ has a rather large bandgap, making these materials more versatile as candidates for thin, flexible device applications and useful for a variety of other applications including lubrication¹⁶, catalysis¹⁷, transistors¹⁸ and lithium-ion batteries¹⁹. Most interestingly, an indirect to direct bandgap transition in the monolayer limit has been predicted theoretically and supported experimentally by optical measurements^{3–5,9,12}. Because of the direct bandgap, monolayer MX₂ is favourable for optoelectronic applications⁵ and field-effect transistors^{15,16,18}. Furthermore, both the conduction and valence bands have two energy degenerate valleys at corners of the first Brillouin zone, making it viable to optically control the charge carriers in these valleys and suggesting the possibility of valley-based electronic and optoelectronic applications^{3,6–8}. Despite these exciting developments, direct experimental verification of the novel band structure at the monolayer limit remains lacking. Furthermore, for many

applications, it is vital to manufacture high-quality epitaxial films with controllable methods such as chemical vapour deposition (CVD) or molecular beam epitaxy (MBE)^{20,21}.

In this Letter, we report layer-by-layer growth of high-quality single-crystal MoSe₂ thin films by MBE on an epitaxial graphene-terminated 6H-SiC(0001) substrate²². Our *in situ* angle-resolved photoemission spectroscopic (ARPES) study provides the first direct experimental evidence of the distinct transition in the band-structure for thin film samples with thicknesses ranging from one monolayer (ML) to eight monolayers. Moreover, we find rather large spin-splitting (~180 meV) at the valence band maximum (VBM) of the monolayer MoSe₂ film, a signature of the combined effects of spin-orbit coupling and inversion symmetry breaking.

Figure 1a presents the crystal structure of the layered MoSe₂. Each single layer (Se-Mo-Se) of MoSe₂ consists of two layers of Se atoms on opposite faces, with one layer of Mo atoms inserted in the middle. Figure 1b shows the reflection high-energy electron diffraction (RHEED) pattern of our substrate of epitaxial bilayer graphene-terminated 6H-SiC(0001)²². The similar layered structure and chemically inert surface of graphene make it a perfect substrate for van der Waals epitaxial growth of two-dimensional layered materials^{21,23,24}. We have successfully grown high-quality single-crystal MoSe₂ films of large size (~5 mm × 2 mm), from monolayer up to 8 ML, with layer-by-layer control of thickness, by delicate control of the growth conditions. Here, we use the term ‘monolayer’ to refer to the one-unit-cell triple layer (Se-Mo-Se) of MoSe₂ (correspondingly, the terms ‘bilayer’ and ‘trilayer’ refer to two and three layers of the Se-Mo-Se structure). Figure 1c presents the RHEED pattern for our MBE-grown monolayer MoSe₂ thin film. The disappearance of the graphene pattern (Fig. 1b) and the appearance of a distinct MoSe₂ (1 × 1) pattern (Fig. 1c), which is insensitive to both sample (~5 mm × 2 mm) and beam positions, indicate the growth of a homogeneously well-structured film. Figure 1e makes a direct comparison of our calculated band structures (Fig. 1d) and the corresponding ARPES spectra (Fig. 1f) of the monolayer MoSe₂ film along the Γ -K direction in the hexagonal Brillouin zone. The contribution from bilayer graphene is not visible in this momentum window, because it centres further in k_y , the momentum along the Γ -K direction for both MoSe₂ films and graphene, at the K point of the bilayer graphene substrate (Supplementary Figs 1, 2). Despite the energy scale difference, the calculation and ARPES spectra show good qualitative agreement. Renormalizing the energy scale of calculation by ~17%, we found that the calculated bands (dotted lines in Fig. 1e) are in good

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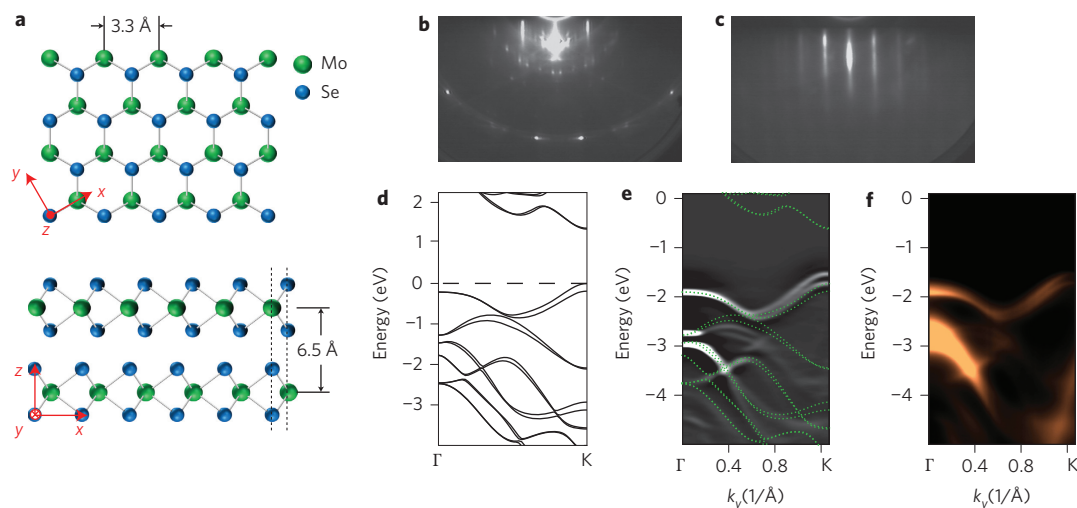


Figure 1 | Crystal structure, RHEED patterns and overall ARPES spectra of MoSe₂ thin film. **a**, Crystal structure of MoSe₂. **b,c**, RHEED patterns of epitaxial bilayer graphene over a 6H-SiC(0001) substrate (**b**) and a monolayer MoSe₂ thin film grown on the substrate (**c**). **d**, Theoretical band structures calculated using GGA along the Γ -K direction of the monolayer MoSe₂ film. Zero energy represents the VBM. **e, f**, Direct comparison of theoretical and experimental band structures of the monolayer MoSe₂ film (**e**). The experimental band structure is shown in **e** as a second derivative of the data in **f** to enhance visibility (black and white intensity plot), and the overlaid green dotted lines are the calculated band structures with renormalized energy scale. k_y refers to the momentum along the Γ -K direction, corresponding to the y axis shown in **a**.

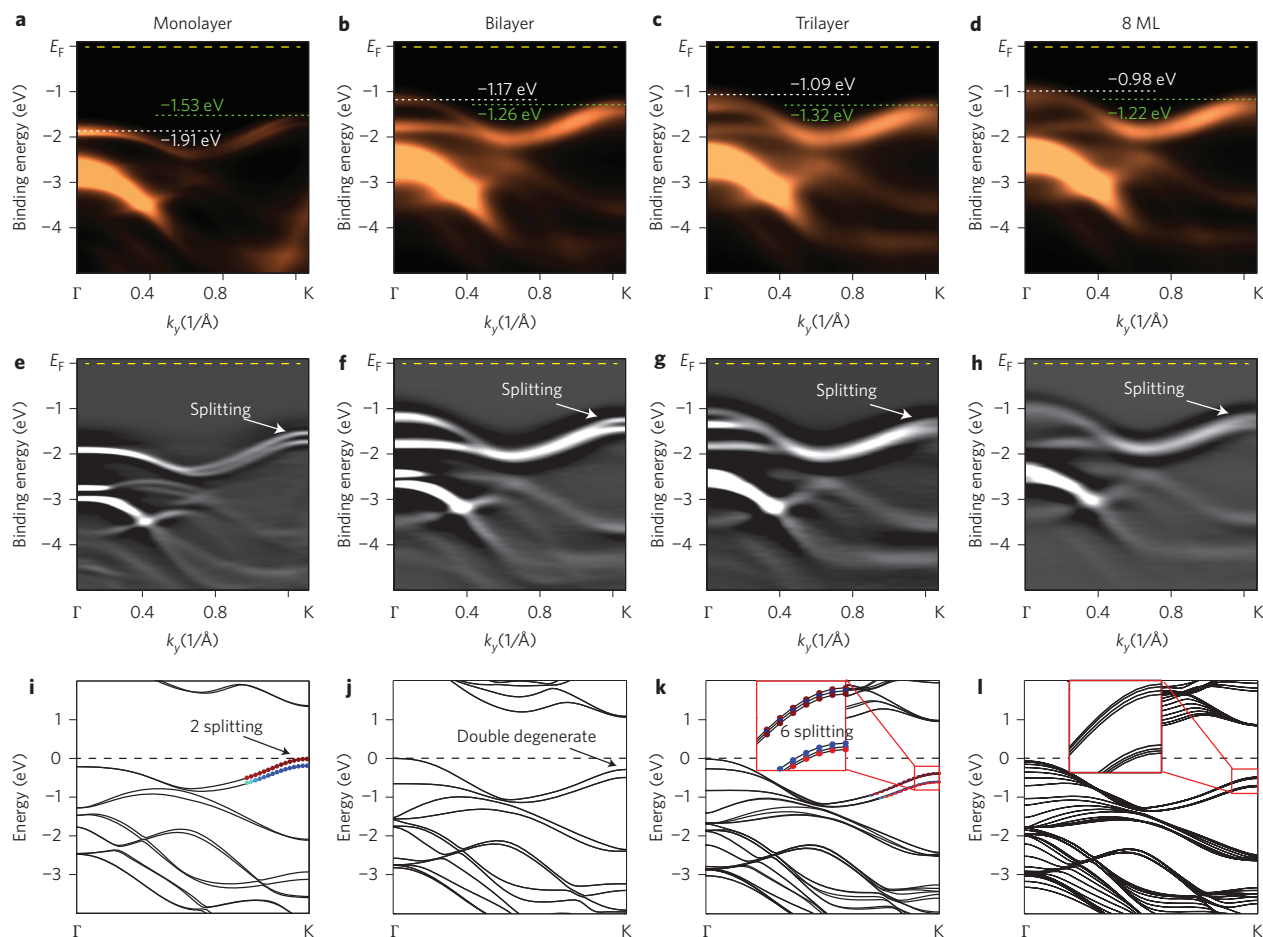


Figure 2 | Band evolution with increasing thickness of MoSe₂ thin films. **a-d**, ARPES spectra of monolayer, bilayer, trilayer and 8 ML MoSe₂ thin films along the Γ -K direction. White and green dotted lines indicate the energy positions of the apices of valence bands at the Γ and K points, respectively, with energy values written in the same colours. **e-h**, Second-derivative spectra of **a-d**, respectively, to enhance the visibility of some bands. Yellow dashed lines indicate the Fermi level. **i-l**, Calculated band structures of monolayer, bilayer, trilayer and 8 ML MoSe₂. Insets to **k** and **l**: zoom-in splitting of the valence band at the K point. Blue and red circles in **k** indicate opposite spin directions.

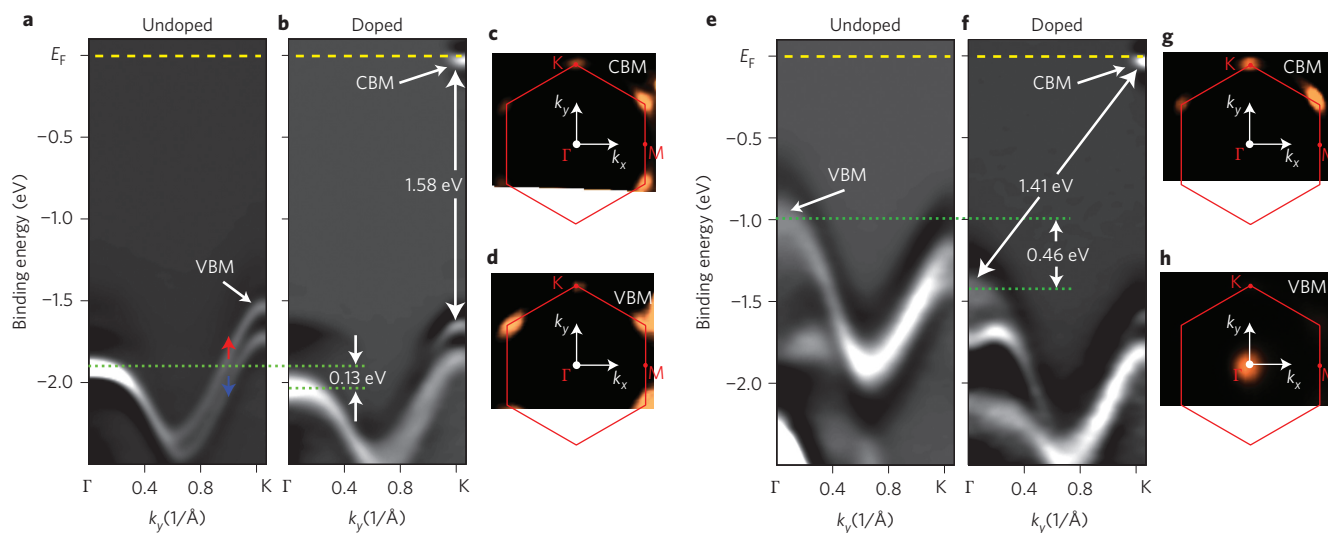


Figure 3 | Direct bandgap in monolayer and indirect bandgap in 8 ML MoSe₂ thin films. a–d, ARPES data for the monolayer sample. **e–h**, ARPES data for the 8 ML sample. **a,e**, Second-derivative spectra of undoped monolayer (**a**) and 8 ML MoSe₂ (**e**) films along the Γ -K direction. **b,f**, Second-derivative spectra along the Γ -K direction after potassium surface doping to shift the chemical potential and reveal the CBM in monolayer and 8 ML MoSe₂ thin films, respectively. Yellow dashed lines are Fermi levels. Blue and red arrows in **a** indicate the opposite spin directions of the spin-split states near the K point in the monolayer MoSe₂ film. Green dotted lines indicate the valence bands in monolayer and 8 ML MoSe₂ films, moved by 0.13 eV and 0.46 eV with potassium doping, respectively. **c,g**, Constant energy maps at the CBM of potassium-doped monolayer and 8 ML MoSe₂ films, respectively. **d,h**, Constant energy maps at the VBM of undoped monolayer and 8 ML MoSe₂ films, respectively. Red hexagons indicate the first Brillouin zone of the system. k_x and k_y refer to the momentum along the Γ -K and Γ -M directions, corresponding to the x and y axes shown in Fig. 1a, respectively.

agreement with the second-derivative spectra (Fig. 1e). More interestingly, the difference in the relative position of the valence bands at the Γ point and K point in the monolayer film is significantly larger than that obtained from the theory, indicating that MoSe₂ shows a stronger tendency towards a direct bandgap material than predicted theoretically.

Figure 2a–d presents the ARPES spectra of monolayer, bilayer, trilayer and 8 ML MoSe₂ films, respectively. The second-derivative spectra in Fig. 2e–h are provided to enhance the visibility. Comparisons with our calculations based on the generalized gradient approximation (GGA²⁵; Fig. 2i–l) clearly show that the thickness-dependent band structure evolution is highly consistent with theoretical calculations. In particular, in the spectra from the monolayer MoSe₂ film (Fig. 2a,e), the VBM at the K point (−1.53 eV) is significantly higher than the Γ point valence band (−1.91 eV). However, in bilayer and thicker films, the VBM switches to the Γ point (Fig. 2a–h). The quantum confinement effect, which can reveal the number of layers, can be seen around the top valence band at the Γ point. In monolayer MoSe₂ film there is only one band above the binding energy of −2 eV at the Γ point (Fig. 2a,e), but in the bilayer film this band evolves into two branches, and then to three branches in the trilayer film (Fig. 2a–h). In the 8 ML film, the calculation (Fig. 2l) shows the presence of eight branches, although in Fig. 2d and h we can only see two main, broad branches due to the limited resolution (these branches are quite close to each other). This significant step-by-step evolution of the valence band provides a straightforward method to identify the thickness of ultrathin MoSe₂ films, and also provides verification of the layer-by-layer growth mode of our thin film.

Figure 3a,b presents the second-derivative spectra of undoped and potassium-doped monolayer MoSe₂ films, respectively. With surface doping with potassium, we can raise the chemical potential of the MoSe₂ film (the green dashed lines in Fig. 3a,b indicate the \sim 130 meV movement of the valence band). This enabled us to observe how the conduction band minimum (CBM) dropped below the Fermi level in potassium-doped monolayer MoSe₂ film (Fig. 3b). Figure 3c,d shows the constant energy maps at the CBM

(Fig. 3b) and VBM (Fig. 3a). We can see that both the CBM and VBM are located at all the K points in the Brillouin zone (no photoemission intensity was observed at the Γ point), which implies the presence of a direct bandgap at the six K points in monolayer MoSe₂. In Fig. 3b we measured this direct bandgap to be \sim 1.58 eV, which is very close to the value of 1.55 eV reported by a photoluminescence experiment in mechanically exfoliated monolayer MoSe₂ (ref. 4).

Figure 3e,f shows the second-derivative spectra of undoped and potassium-doped 8 ML MoSe₂ films, respectively. With the same doping method, we found that the valence band moved by \sim 0.46 eV. We can also observe the CBM in the spectra of potassium-doped 8 ML MoSe₂ film (Fig. 3f). Figure 3g,h presents the constant energy maps at the CBM (Fig. 3f) and VBM (Fig. 3e). In contrast to the monolayer MoSe₂, in the 8 ML MoSe₂ film the CBM is still at the six K points (Fig. 3g), but the VBM is at the Γ point (Fig. 3h). Thus, the 8 ML MoSe₂ displays an indirect bandgap of \sim 1.41 eV (Fig. 3f). We note that the calculated GGA bandgap values (Fig. 2i–l) are underestimated, which is a well-known problem in that GGA density functional theory generally underestimates the bandgaps in semiconductors and insulators⁹.

From monolayer to 8 ML, we found that the CBM does not change its position at the K point. Our calculations also show that the CBM stays at the K point. However, from monolayer to bilayer and thicker films, both our ARPES spectra and the calculations show that the VBM switches from the K point to the Γ point. Because the interaction between the graphene substrate and the van der Waals epitaxial MoSe₂ film is found to be minimal in both experiment (Supplementary Fig. 3) and calculation (Supplementary Fig. 4), this VBM evolution clearly indicates the direct to indirect bandgap transition in going from monolayer to bilayer MoSe₂.

Another interesting observation is that we found a very clear band-splitting of the VBM at the K point of monolayer MoSe₂ film (Figs 2a,e and 3a). A similar band-splitting can also be seen in bilayer, trilayer and 8 ML MoSe₂ films (Fig. 2f–h). Our calculations show that this splitting is mainly controlled by the strength

of the spin–orbit coupling. For an odd number of layers, there is no inversion symmetry, and each state at the K point is spin-nondegenerate (Fig. 2i and inset of Fig. 2k, where red and blue round spots indicate different spin polarization). For an even number of layers, inversion symmetry is restored, and every state becomes spin-degenerate (Fig. 2j and inset of Fig. 2l). The combined effects of the spin–orbit coupling and inversion symmetry-breaking can be best seen by a comparison between monolayer and bilayer MoSe₂ films. In the monolayer MoSe₂ film, each state at the K point is spin-nondegenerate while states at the Γ point are spin-degenerate (because K is not a time-reversal-invariant point, but Γ is). The top two branches that start at the K point, merging into one branch at the Γ point, are observed both in the experiment (Fig. 2a,e) and theory (Fig. 2i). Each spin split state is predicted to be nearly 100% spin-polarized (Fig. 2i). Such a high degree of spin polarization has also recently been predicted in silicene thin films in proposals for a high-efficiency spin filter²⁶. In bilayer MoSe₂ film, the band is doubly degenerate without spin-splitting (Fig. 2j). Both experiment and theory exhibit two branches on top of the valence bands at both the Γ and K points (Fig. 2f,j). In the trilayer MoSe₂ film, the magnitude of the spin-splitting within the two main branches is only a few meV, making them nearly degenerate (inset of Fig. 2k), so we can only observe two branches in ARPES in Fig. 2g. In the 8 ML thin film, the calculated eight spin-degenerate states at the K point (inset in Fig. 2l) merge into two blurred branches in the ARPES spectra (Fig. 2h). Our finding of the spin-splitting of ~ 180 meV in monolayer MoSe₂ is consistent with a previous theoretical prediction (183 meV)¹⁰ and larger than that in monolayer MoS₂ (as measured recently by triply resonant Raman scattering: ~ 100 meV)²⁷. This spin signature with larger spin-splitting gives the layered MoSe₂ greater application potential than MoS₂ in spintronic devices, as well as a new basis on which to investigate spin–orbit physics beyond topological insulators²⁸.

To summarize, we have successfully achieved layer-by-layer growth of high-quality MoSe₂ thin films using MBE. The ARPES study shows a distinct transition from an indirect bandgap of ~ 1.41 eV to a direct bandgap ~ 1.58 eV when the layer thickness changes from 8 ML to monolayer. Together with the corresponding first-principles computations, this not only provides direct experimental proof of the novel electronic structure evolution, but also reveals clear spin-split bands only in the monolayer limit.

Methods

Thin film growth and ARPES. This experiment was performed at the HERS endstation of beamline 10.0.1, Advanced Light Sources, Lawrence Berkeley National Laboratory. Thin-film samples of MoSe₂ were grown in the MBE chamber at the beamline, with a base pressure of $\sim 2 \times 10^{-10}$ torr, and then transferred directly into the analysis chamber (base pressure of $\sim 3 \times 10^{-11}$ torr) immediately before ARPES measurements. Bilayer graphene substrates were prepared by flash annealing of the 6H-SiC(0001) to 1,300 °C (ref. 22). High-purity Mo and Se were evaporated from an electron-beam evaporator and a standard Knudsen cell, respectively. The flux ratio of Mo to Se was controlled to be ~ 1.8 . The growth process was monitored by an *in situ* RHEED system and the growth rate was ~ 8.5 min per monolayer. During the growth process the substrate temperature was kept at 250 °C, and after growth the sample was annealed to 600 °C for 30 min. The potassium for surface doping was evaporated from a SAES Getters alkali metal dispenser. The ARPES data were taken with a Scienta R4000 electron analyser. Samples were cooled to 40 K with liquid helium during measurements. The photon energy was set at 70 eV, with energy and angular resolution of 25 meV and 0.1°, respectively. The photon polarization direction was set to be 72° out of the plane of incidence to obtain an evenly distributed even and odd state signal. The size of the beam spot on the sample was $\sim 150 \mu\text{m} \times 200 \mu\text{m}$. We did not find any change in the observed ARPES spectra when changing the beam position around the sample ($\sim 5 \text{ mm} \times 2 \text{ mm}$), suggesting the homogeneity of our sample.

Electronic structure calculations. The electronic structures were calculated using the full-potential projected augmented-wave method²⁹ as implemented in the VASP package³⁰ within the GGA scheme²⁵. Spin–orbit coupling was included self-consistently, and a 15×15 Monkhorst–Pack k-point mesh was used. The thin films were modelled as slabs separated by vacuum with a thickness of ~ 15 Å.

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References

- Klitzing, K. v., Dorda, G. & Pepper, M. New method for high-accuracy determination of the fine-structure constant based on quantized Hall resistance. *Phys. Rev. Lett.* **45**, 494–497 (1980).
- Geim, A. K. Graphene: status and prospects. *Science* **324**, 1530–1534 (2009).
- Mak, K. F. *et al.* Atomically thin MoS₂: a new direct-gap semiconductor. *Phys. Rev. Lett.* **105**, 136805 (2010).
- Tongay, S. *et al.* Thermally driven crossover from indirect toward direct bandgap in 2D semiconductors: MoSe₂ versus MoS₂. *Nano Lett.* **12**, 5576–5580 (2012).
- Splendiani, A. *et al.* Emerging photoluminescence in monolayer MoS₂. *Nano Lett.* **10**, 1271–1275 (2010).
- Cao, T. *et al.* Valley-selective circular dichroism of monolayer molybdenum disulphide. *Nature Commun.* **3**, 887 (2012).
- Zeng, H. *et al.* Valley polarization in MoS₂ monolayers by optical pumping. *Nature Nanotech.* **7**, 490–493 (2012).
- Xiao, D. *et al.* Coupled spin and valley physics in monolayers of MoS₂ and other group-VI dichalcogenides. *Phys. Rev. Lett.* **108**, 196802 (2012).
- Ellis, J. K., Lucero, M. J. & Scuseria, G. E. The indirect to direct band gap transition in multilayered MoS₂ as predicted by screened hybrid density functional theory. *Appl. Phys. Lett.* **99**, 261908 (2011).
- Zhu, Z. Y., Cheng, Y. C. & Schwingschögl, U. Giant spin–orbit-induced spin splitting in two-dimensional transition-metal dichalcogenide semiconductors. *Phys. Rev. B* **84**, 153402 (2011).
- Cheiwchanamnanjij, T. & Lambrecht, W. R. L. Quasiparticle band structure calculation of monolayer, bilayer, and bulk MoS₂. *Phys. Rev. B* **85**, 205302 (2012).
- Kumar, A. & Ahluwalia, P. K. Electronic structure of transition metal dichalcogenides monolayers 1H-MX₂ (M=Mo, W; X=S, Se, Te) from *ab-initio* theory: new direct band gap semiconductors. *Eur. Phys. J. B* **85**, 186 (2012).
- Balandran, S. *et al.* Two-dimensional molybdenum trioxide and dichalcogenides. *Adv. Funct. Mater.* **23**, 3952–3970 (2013).
- Radisavljevic, B. *et al.* Single-layer MoS₂ transistors. *Nature Nanotech.* **6**, 147–150 (2011).
- Larentis, S., Fallahzad, B. & Tutuc, E. Field-effect transistors and intrinsic mobility in ultra-thin MoSe₂ layers. *Appl. Phys. Lett.* **101**, 223104 (2012).
- Lee, C. *et al.* Frictional characteristics of atomically thin sheets. *Science* **328**, 76–80 (2010).
- Laursen, A. B., Kegnæs, S., Dahl, S. & Chorkendorff, I. Molybdenum sulfides—efficient and viable materials for electro- and photoelectrocatalytic hydrogen evolution. *Energy Environ. Sci.* **5**, 5577–5591 (2012).
- Yoon, Y., Ganapathi, K. & Salahuddin, S. How good can monolayer MoS₂ transistors be? *Nano Lett.* **11**, 3768–3773 (2011).
- Chang, K. & Chen, W. *In situ* synthesis of MoS₂/graphene nanosheet composites with extraordinarily high electrochemical performance for lithium ion batteries. *Chem. Commun.* **47**, 4252 (2011).
- Liu, K.-K. *et al.* Growth of large-area and highly crystalline MoS₂ thin layers on insulating substrates. *Nano Lett.* **12**, 1538–1544 (2012).
- Shi, Y. *et al.* Van der Waals epitaxy of MoS₂ layers using graphene as growth templates. *Nano Lett.* **12**, 2784–2791 (2012).
- Wang, Q. *et al.* Large-scale uniform bilayer graphene prepared by vacuum graphitization of 6H-SiC(0001) substrates. *J. Phys.* **25**, 095002 (2013).
- Zhang, Y. *et al.* Crossover of the three-dimensional topological insulator Bi₂Se₃ to the two-dimensional limit. *Nature Phys.* **6**, 584–588 (2010).
- Koma, A. Van der Waals epitaxy—a new epitaxial growth method for a highly lattice-mismatched system. *Thin Solid Films* **216**, 72–76 (1992).
- Perdew, J. P., Burke, K. & Ernzerhof, M. Generalized gradient approximation made simple. *Phys. Rev. Lett.* **77**, 3865–3868 (1996).
- Tsai, W.-F. *et al.* Gated silicene as a tunable source of nearly 100% spin-polarized electrons. *Nature Commun.* **4**, 1500 (2013).
- Sun, L. *et al.* Spin–orbit splitting in single-layer MoS₂ revealed by triply resonant Raman scattering. *Phys. Rev. Lett.* **111**, 126801 (2013).
- Hasan, M. Z. & Kane, C. L. *Colloquium*: topological insulators. *Rev. Mod. Phys.* **82**, 3045–3067 (2010).
- Blöchl, P. E. Projector augmented-wave method. *Phys. Rev. B* **50**, 17953–17979 (1994).
- Kresse, G. & Furthmüller, J. Efficient iterative schemes for *ab initio* total-energy calculations using a plane-wave basis set. *Phys. Rev. B* **54**, 11169–11186 (1996).

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Author contributions

Y.Z. led the thin-film growth effort with F.S., J.L., R.M. and S.K.M., performed ARPES measurements with B.Z., Z.L. and S.K.M., and analysed the data. Y.Z., H.L. and S.K.M.

wrote the paper with suggestions and comments by A.B. and Z.X.S. Y.T.C. and Y.H. characterized samples with Raman spectroscopy and AFM. T.R.C., H.L., H.T.J. and A.B. provided theoretical support. S.K.M., Y.L.C., Z.H., A.B. and Z.X.S. were responsible for project direction, planning and infrastructure.

Additional information

Supplementary information is available in the [online version](#) of the paper. Reprints and permissions information is available online at www.nature.com/reprints. Correspondence and requests for materials should be addressed to S.K.M. and Z.X.S.

Competing financial interests

The authors declare no competing financial interests.